

<b>Notice of References Cited</b>		Application/Control No. 10/523,279	Applicant(s)/Patent Under Reexamination JONES ET AL.	
		Examiner SAMIRA JEAN-LOUIS	Art Unit 1617	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,331,536 B1	12-2001	Radulovacki et al.	514/214.02
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 037461	06-2000	WIPO	Bosmans et al.	405/12
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Matsui et al. PNAS 2000, Vol. 97, No. 17, pgs. 9579-9584
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))  
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